

<b>Notice of References Cited</b>	Application/Control No. 10/015,569	Applicant(s)/Patent Under Reexamination WANG ET AL.	
	Examiner Heather D. Gibbs	Art Unit 2625	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,046,826	04-2000	Lu et al.	358/475
*	B	US-6,864,998	03-2005	Kito et al.	358/471
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N	JP 10197969 A	07-1998	Japan	NAKAMURA, HITOSHI	
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	X	

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